

<b>Notice of References Cited</b>	Application/Control No. 10/665,870	Applicant(s)/Patent Under Reexamination MARGANSKI ET AL.	
	Examiner Robert H. Spitzer	Art Unit 1724	Page 1 of 3

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2,096,851	10-1937	Fricke, William John	96/132
	B	US-2,384,502	09-1945	STREICHER, JOHANN S	423/659
	C	US-3,068,070	12-1962	FELCH, ELROY L	423/323
	D	US-3,169,112	02-1965	NELSON, ROY A	210/266
	E	US-4,111,833	09-1978	Evans, A. Gary	502/401
	F	US-4,224,040	09-1980	Gazzarrini et al.	95/133
	G	US-4,421,533	12-1983	Nishino et al.	95/138
	H	US-4,871,524	10-1989	Allen, Robert H.	423/349
	I	US-5,024,682	06-1991	Turk, Amos	95/136
	J	US-5,064,805	11-1991	Otowa, Yoshiro	502/427
	K	US-5,601,702	02-1997	Yan, Tsoung Y.	208/308
	L	US-5,607,576	03-1997	Yan, Tsoung Y.	208/308
	M	US-5,728,198	03-1998	Acharya et al.	95/114

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/665,870	Applicant(s)/Patent Under Reexamination MARGANSKI ET AL.	
	Examiner Robert H. Spitzer	Art Unit 1724	Page 2 of 3

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,769,928	06-1998	Leavitt, Frederick Wells	95/95
	B	US-6,007,706	12-1999	Carnell et al.	208/303
	C	US-6,106,593	08-2000	Golden et al.	95/120
	D	US-6,152,991	11-2000	Ackley, Mark William	95/96
	E	US-6,325,841	12-2001	Otsuka et al.	95/132
	F	US-6,338,312	01-2002	Hayes et al.	118/723CB
	G	US-6,461,411	10-2002	Watanabe et al.	95/116
	H	US-6,599,347	07-2003	Kalbassi et al.	95/10
	I	US-6,843,830	01-2005	Sherer, John Michael	95/90
	J	US-2002/0014153	02-2002	BAKSH et al.	95/96
	K	US-2002/0100366	08-2002	Watanabe et al.	95/116
	L	US-2003/0097932	05-2003	Watanabe et al.	95/116
	M	US-2003/0164092	09-2003	Golden et al.	95/96

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/665,870	Applicant(s)/Patent Under Reexamination MARGANSKI ET AL.	
	Examiner Robert H. Spitzer	Art Unit 1724	Page 3 of 3

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0200866	10-2003	Weyrich et al.	95/129
	B	US-2004/0107833	06-2004	Sweeney et al.	095/116
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.